

Notice of References Cited	Application/Control No. 10/004,447	Applicant(s)/Patent Under Reexamination YARDUMIAN ET AL.	
	Examiner Cong-Lac Huynh	Art Unit 2178	Page 1 of 1

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	B	US-2002/0163545	11-2002	Hii, Samuel S.	345/838
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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